

STFW45N65M5, STW45N65M5, STWA45N65M5

N-channel 650 V, 35 A, 0.067 Ω typ., MDmesh™ V Power MOSFETs
in TO-3PF, TO-247 and TO-247 long leads packages

Datasheet - production data

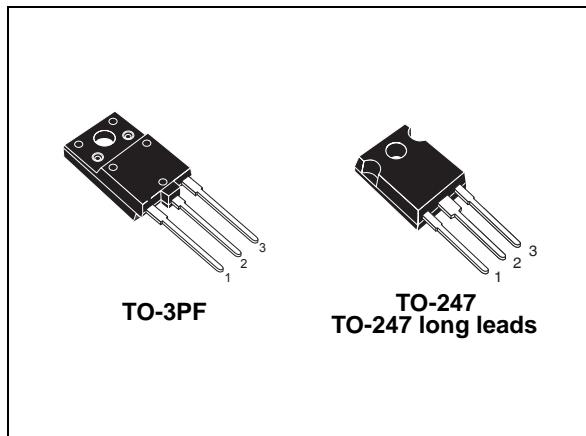
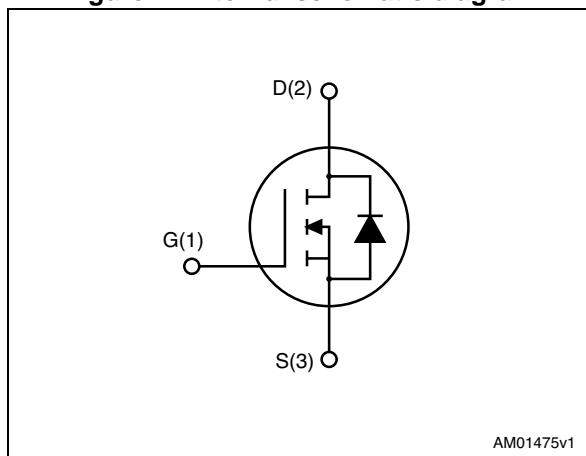


Figure 1. Internal schematic diagram



Features

| Order codes | V_{DS} @ T_{Jmax} | $R_{DS(on)}$ max | I_D |
|-------------|-----------------------|------------------|-------|
| STFW45N65M5 | 710 V | 0.078 Ω | 35 A |
| STW45N65M5 | | | |
| STWA45N65M5 | | | |

- Worldwide best $R_{DS(on)}$ * area
- Higher V_{DSS} rating and high dv/dt capability
- Excellent switching performance
- 100% avalanche tested

Applications

- Switching applications

Description

These devices are N-channel MDmesh™ V Power MOSFETs based on an innovative proprietary vertical process technology, which is combined with STMicroelectronics' well-known PowerMESH™ horizontal layout structure. The resulting product has extremely low on-resistance, which is unmatched among silicon-based Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

Table 1. Device summary

| Order codes | Marking | Package | Packaging |
|-------------|---------|-------------------|-----------|
| STFW45N65M5 | 45N65M5 | TO-3PF | Tube |
| STW45N65M5 | | TO-247 | |
| STWA45N65M5 | | TO-247 long leads | |

Contents

| | | |
|----------|-------------------------------------|-----------|
| 1 | Electrical ratings | 3 |
| 2 | Electrical characteristics | 4 |
| 2.1 | Electrical characteristics (curves) | 6 |
| 3 | Test circuits | 9 |
| 4 | Package mechanical data | 10 |
| 4.1 | TO-3PF, STFW45N65M5 | 11 |
| 4.2 | TO-247, STW45N65M5 | 13 |
| 4.3 | TO-247 long leads, STWA45N65M5 | 15 |
| 5 | Revision history | 17 |

1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | | Unit |
|----------------|---------------------------------------------------------------------------------------------------------------------------|-------------|------------------------------|------------------|
| | | TO-3PF | TO-247, TO-247 long leads | |
| V_{GS} | Gate-source voltage | ± 25 | | V |
| I_D | Drain current (continuous) at $T_C = 25^\circ\text{C}$ | 35 | | A |
| I_D | Drain current (continuous) at $T_C = 100^\circ\text{C}$ | 22 | | A |
| $I_{DM}^{(1)}$ | Drain current (pulsed) | 140 | | A |
| P_{TOT} | Total dissipation at $T_C = 25^\circ\text{C}$ | 57 | 210 | W |
| $dv/dt^{(2)}$ | Peak diode recovery voltage slope | 15 | | V/ns |
| $dv/dt^{(3)}$ | MOSFET dv/dt ruggedness | 50 | | V/ns |
| V_{ISO} | Insulation withstand voltage (RMS) from all three leads to external heat sink ($t=1\text{ s}$; $T_c=25^\circ\text{C}$) | 3500 | | V |
| T_{stg} | Storage temperature | - 55 to 150 | | $^\circ\text{C}$ |
| T_j | Max. operating junction temperature | 150 | | $^\circ\text{C}$ |

1. Limited by maximum junction temperature
2. $I_{SD} \leq 35\text{ A}$, $di/dt \leq 400\text{ A}/\mu\text{s}$, $V_{DS(\text{Peak})} < V_{(\text{BR})DSS}$, $V_{DD} = 400\text{ V}$
3. $V_{DS} < 520\text{ V}$

Table 3. Thermal data

| Symbol | Parameter | Value | | Unit |
|----------------|-----------------------------------------|--------|------------------------------|---------------------------|
| | | TO-3PF | TO-247, TO-247 long leads | |
| $R_{thj-case}$ | Thermal resistance junction-case max | 2.2 | 0.6 | $^\circ\text{C}/\text{W}$ |
| $R_{thj-amb}$ | Thermal resistance junction-ambient max | 50 | 50 | $^\circ\text{C}/\text{W}$ |

Table 4. Avalanche characteristics

| Symbol | Parameter | Value | Unit |
|----------|-----------------------------------------------------------------------------------------------|-------|------|
| I_{AR} | Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax}) | 9 | A |
| E_{AS} | Single pulse avalanche energy (starting $T_j=25^\circ\text{C}$, $I_d=I_{AR}$; $V_{dd}=50$) | 810 | mJ |

2 Electrical characteristics

($T_C = 25^\circ\text{C}$ unless otherwise specified)

Table 5. On /off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------------|--------------------------------------------------|---------------------------------------------------|------|-------|-----------|---------------|
| $V_{(\text{BR})\text{DSS}}$ | Drain-source breakdown voltage | $I_D = 1 \text{ mA}, V_{GS} = 0$ | 650 | | | V |
| I_{DSS} | Zero gate voltage drain current ($V_{GS} = 0$) | $V_{DS} = 650 \text{ V}$ | | | 1 | μA |
| | | $V_{DS} = 650 \text{ V}, T_C = 125^\circ\text{C}$ | | | 100 | μA |
| I_{GSS} | Gate-body leakage current ($V_{DS} = 0$) | $V_{GS} = \pm 25 \text{ V}$ | | | ± 100 | nA |
| $V_{GS(\text{th})}$ | Gate threshold voltage | $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ | 3 | 4 | 5 | V |
| $R_{DS(\text{on})}$ | Static drain-source on-resistance | $V_{GS} = 10 \text{ V}, I_D = 17.5 \text{ A}$ | | 0.067 | 0.078 | Ω |

Table 6. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------------------|---------------------------------------|-----------------------------------------------------------------------------------------------------------|------|------|------|----------|
| C_{iss} | Input capacitance | $V_{DS} = 100 \text{ V}, f = 1 \text{ MHz}, V_{GS} = 0$ | - | 3470 | - | pF |
| C_{oss} | Output capacitance | | - | 82 | - | pF |
| C_{rss} | Reverse transfer capacitance | | - | 7 | - | pF |
| $C_{o(\text{tr})}^{(1)}$ | Equivalent capacitance time related | $V_{DS} = 0 \text{ to } 520 \text{ V}, V_{GS} = 0$ | - | 280 | - | pF |
| $C_{o(\text{er})}^{(2)}$ | Equivalent capacitance energy related | | - | 79 | - | pF |
| R_G | Intrinsic gate resistance | $f = 1 \text{ MHz open drain}$ | - | 2 | - | Ω |
| Q_g | Total gate charge | $V_{DD} = 520 \text{ V}, I_D = 17.5 \text{ A}, V_{GS} = 10 \text{ V}$ (see Figure 18) | - | 82 | - | nC |
| Q_{gs} | Gate-source charge | | - | 18.5 | - | nC |
| Q_{gd} | Gate-drain charge | | - | 35 | - | nC |

- Time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}
- Energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 7. Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max | Unit |
|-------------------|--------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|-----|------|
| $t_d(v)$ | Voltage delay time | $V_{DD} = 400 \text{ V}$, $I_D = 23 \text{ A}$, $R_G = 4.7 \Omega$, $V_{GS} = 10 \text{ V}$ (see Figure 19 and Figure 22) | - | 79.5 | - | ns |
| $t_r(v)$ | Voltage rise time | | - | 11 | - | ns |
| $t_f(i)$ | Current fall time | | - | 9.3 | - | ns |
| $t_c(\text{off})$ | Crossing time | | - | 16 | - | ns |

Table 8. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|-------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|---------------|
| I_{SD} | Source-drain current | | - | | 35 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | - | | 140 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD} = 35 \text{ A}$, $V_{GS} = 0$ | - | | 1.5 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 35 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 100 \text{ V}$ (see Figure 19) | - | 392 | | ns |
| Q_{rr} | Reverse recovery charge | | - | 7.4 | | μC |
| I_{RRM} | Reverse recovery current | | - | 38 | | A |
| t_{rr} | Reverse recovery time | $I_{SD} = 35 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 100 \text{ V}$, $T_j = 150^\circ\text{C}$ (see Figure 19) | - | 468 | | ns |
| Q_{rr} | Reverse recovery charge | | - | 9.7 | | μC |
| I_{RRM} | Reverse recovery current | | - | 42 | | A |

1. Pulse width limited by safe operating area.
2. Pulsed: pulse duration = 300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-3PF

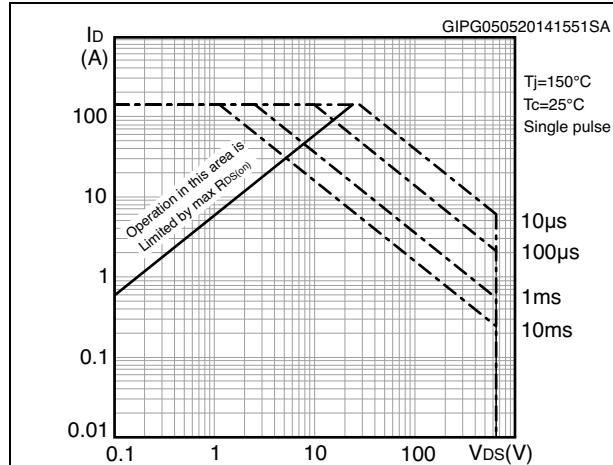


Figure 3. Thermal impedance for TO-3PF

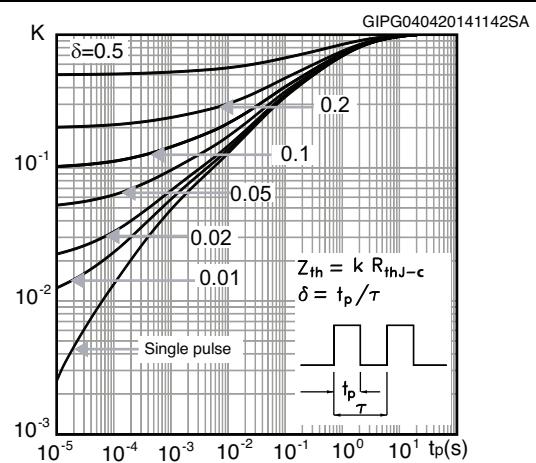


Figure 4. Safe operating area for TO-247 and TO-247LL

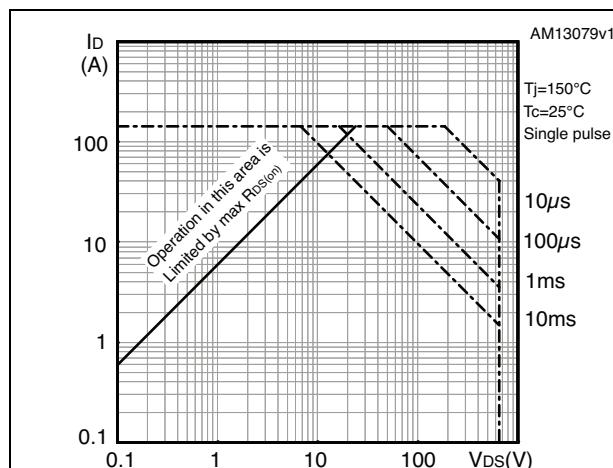


Figure 5. Thermal impedance for TO-247 and TO-247LL

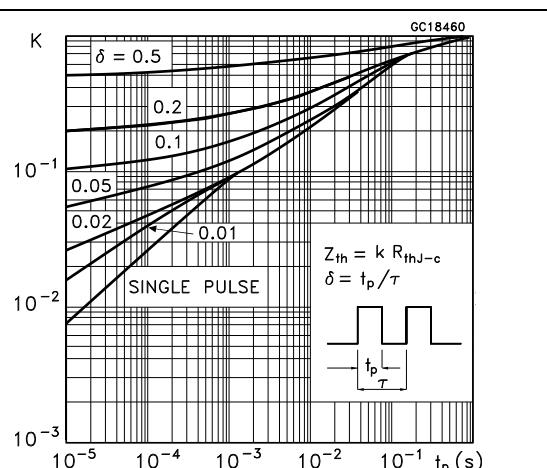


Figure 6. Output characteristics

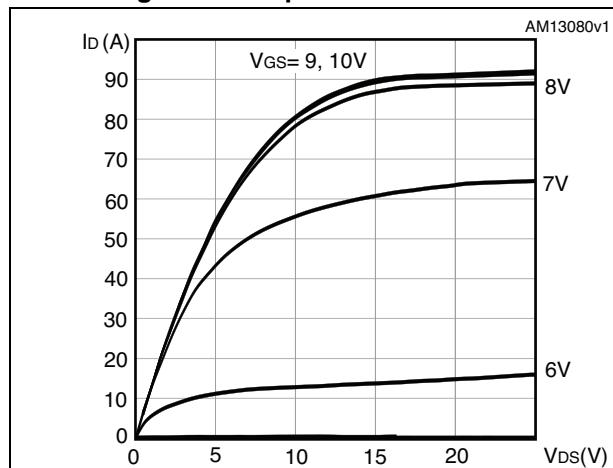


Figure 7. Transfer characteristics

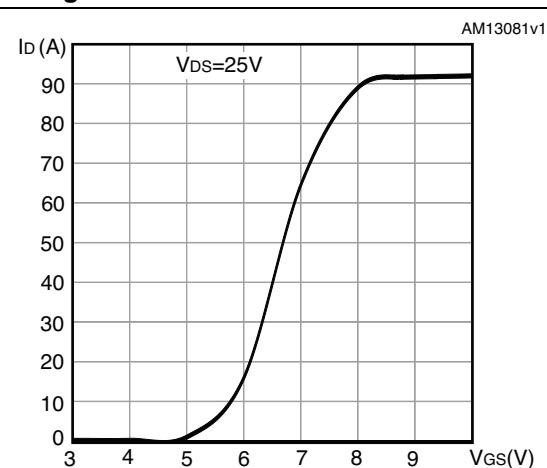


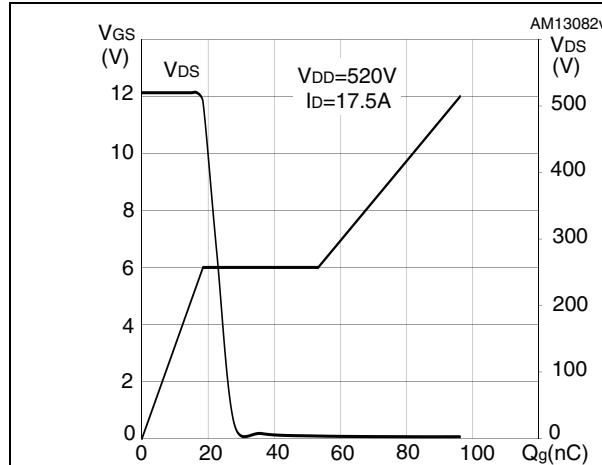
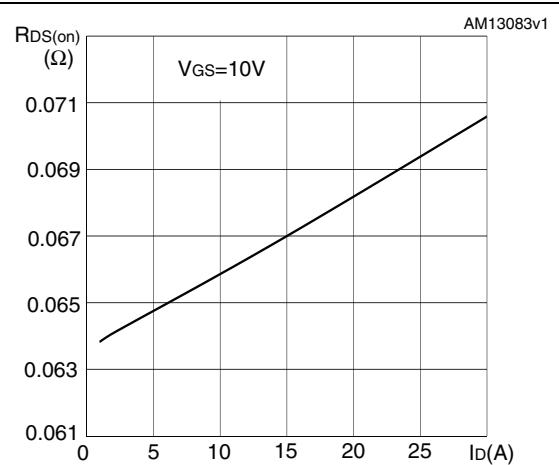
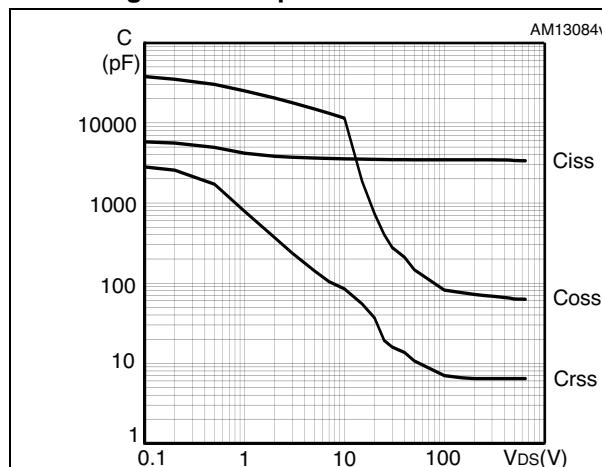
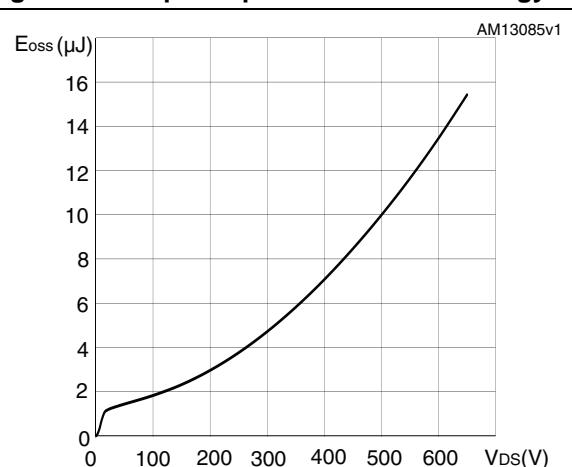
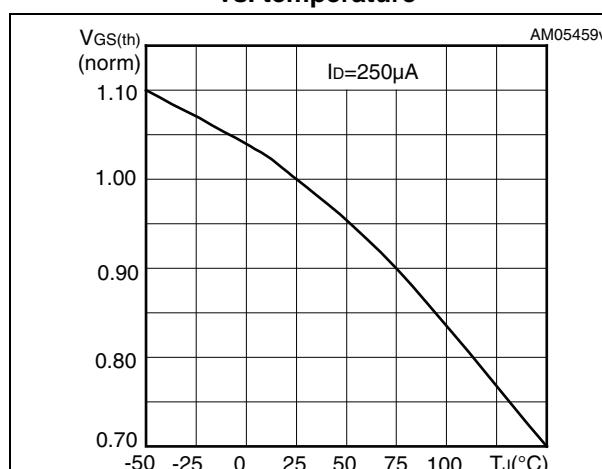
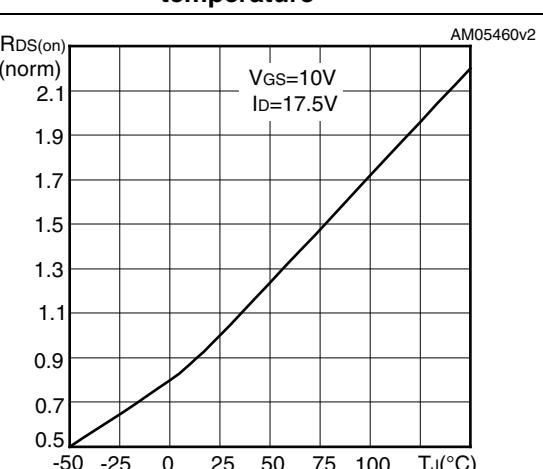
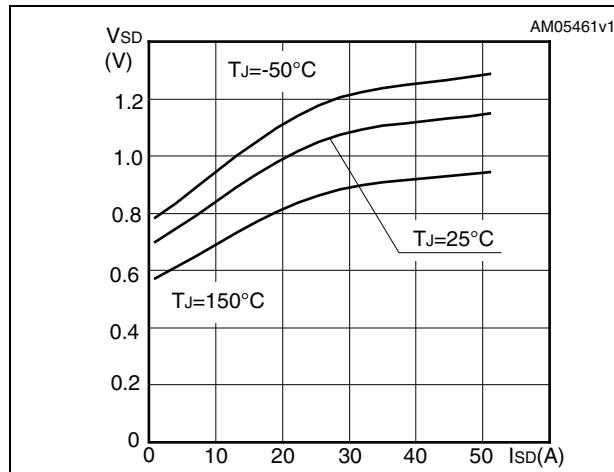
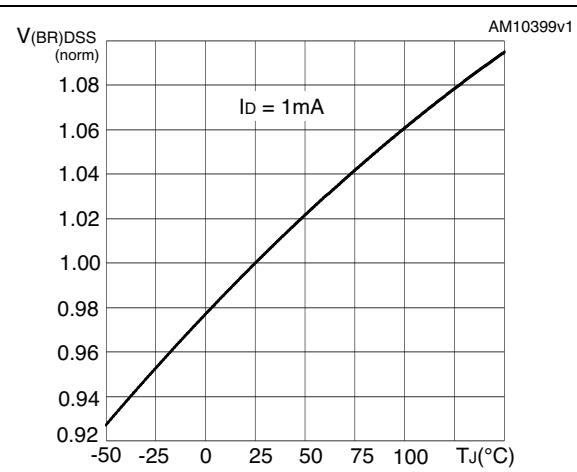
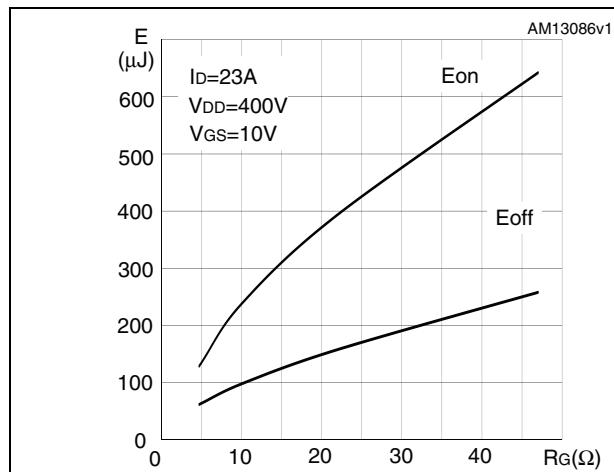
Figure 8. Gate charge vs gate-source voltage**Figure 9. Static drain-source on-resistance****Figure 10. Capacitance variations****Figure 11. Output capacitance stored energy****Figure 12. Normalized gate threshold voltage vs. temperature****Figure 13. Normalized on-resistance vs. temperature**

Figure 14. Drain-source diode forward characteristics**Figure 15. Normalized $V_{(BR)DSS}$ vs. temperature****Figure 16. Switching losses vs. gate resistance⁽¹⁾**

1. E_{on} including reverse recovery of a SiC diode

3 Test circuits

Figure 17. Switching times test circuit for resistive load



Figure 18. Gate charge test circuit

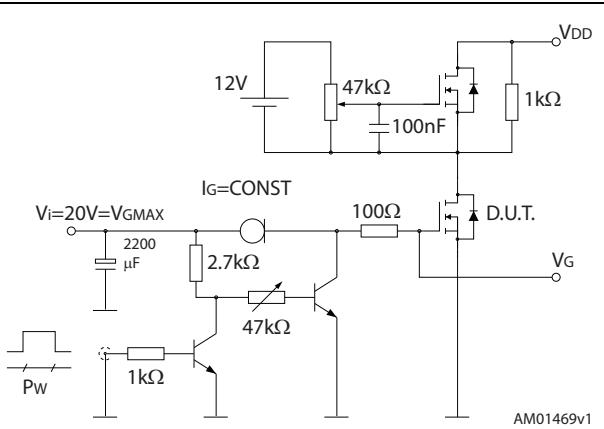


Figure 19. Test circuit for inductive load switching and diode recovery times

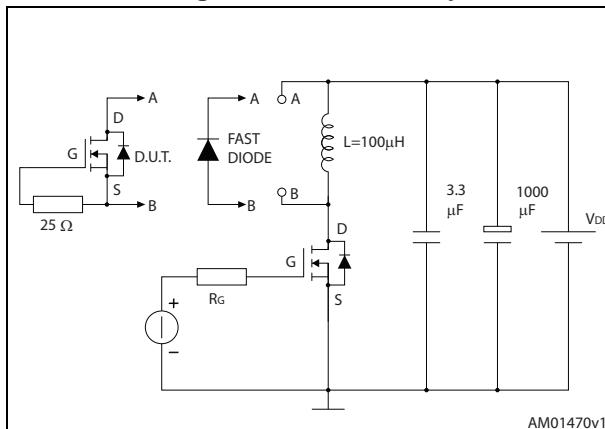


Figure 20. Unclamped inductive load test circuit

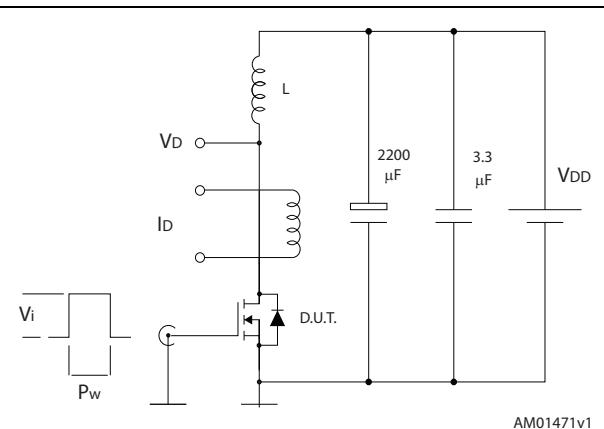


Figure 21. Unclamped inductive waveform

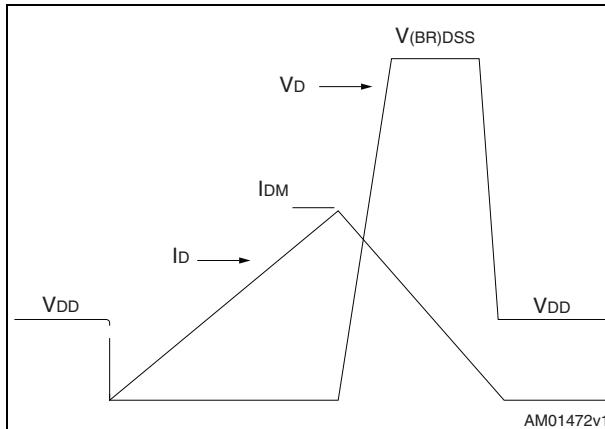
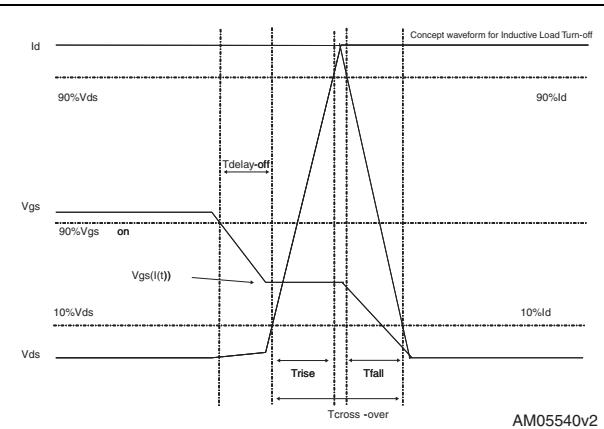


Figure 22. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com.
ECOPACK is an ST trademark.

4.1 TO-3PF, STFW45N65M5

Figure 23. TO-3PF drawing

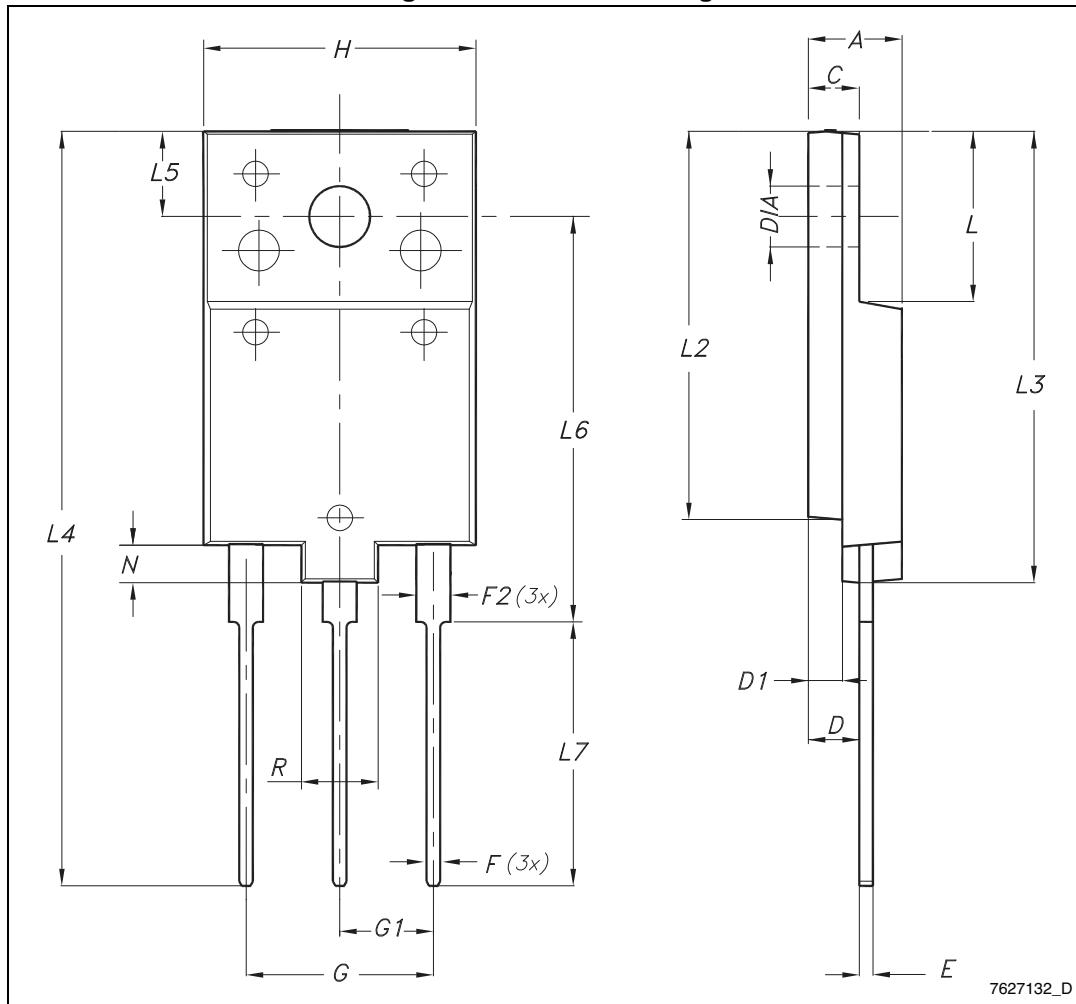


Table 9. TO-3PF mechanical data

| Dim. | mm | | |
|------|-------|------|-------|
| | Min. | Typ. | Max. |
| A | 5.30 | | 5.70 |
| C | 2.80 | | 3.20 |
| D | 3.10 | | 3.50 |
| D1 | 1.80 | | 2.20 |
| E | 0.80 | | 1.10 |
| F | 0.65 | | 0.95 |
| F2 | 1.80 | | 2.20 |
| G | 10.30 | | 11.50 |
| G1 | | 5.45 | |
| H | 15.30 | | 15.70 |
| L | 9.80 | 10 | 10.20 |
| L2 | 22.80 | | 23.20 |
| L3 | 26.30 | | 26.70 |
| L4 | 43.20 | | 44.40 |
| L5 | 4.30 | | 4.70 |
| L6 | 24.30 | | 24.70 |
| L7 | 14.60 | | 15 |
| N | 1.80 | | 2.20 |
| R | 3.80 | | 4.20 |
| Ø | 3.40 | | 3.80 |

4.2 TO-247, STW45N65M5

Figure 24. TO-247 drawing

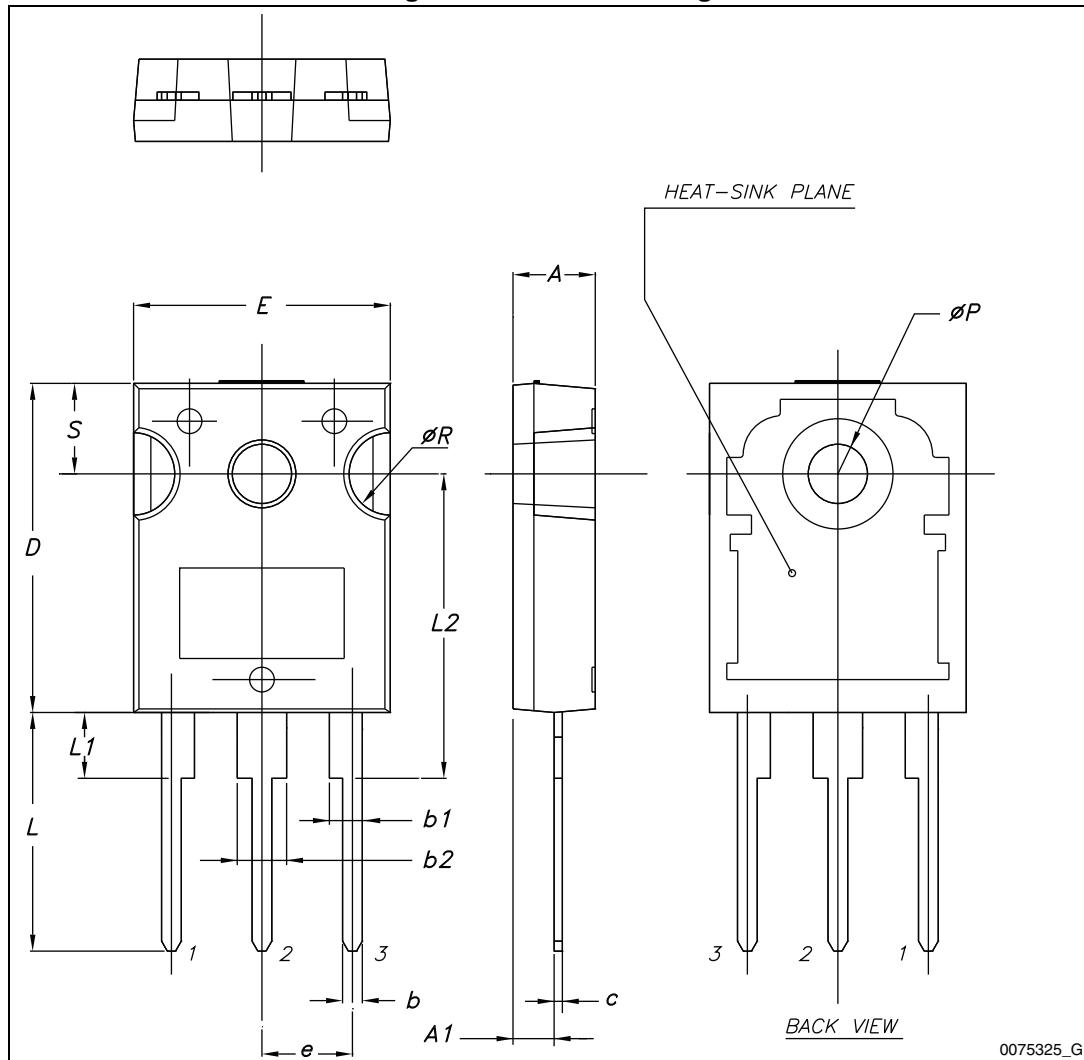
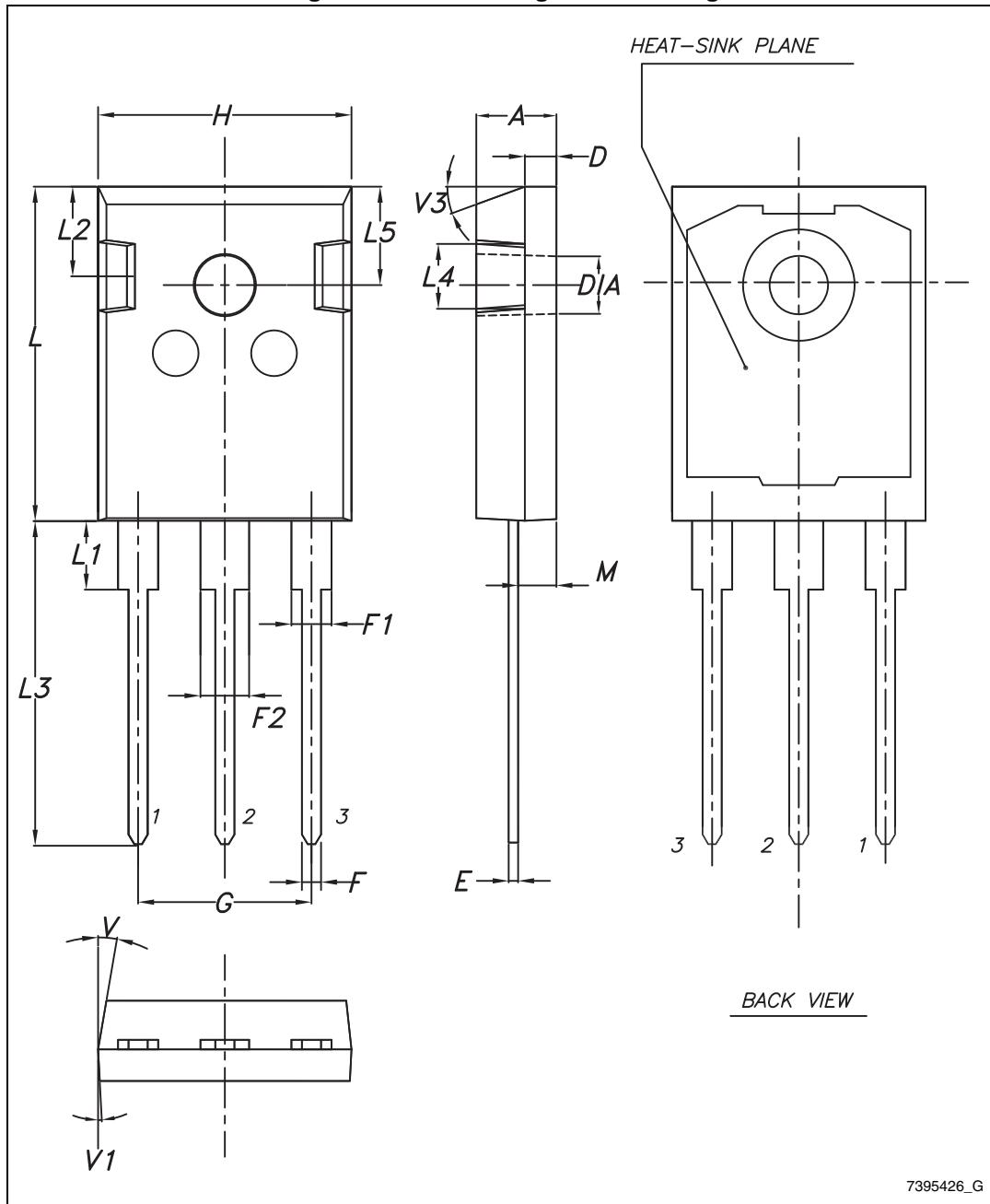


Table 10. TO-247 mechanical data

| Dim. | mm. | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 4.85 | | 5.15 |
| A1 | 2.20 | | 2.60 |
| b | 1.0 | | 1.40 |
| b1 | 2.0 | | 2.40 |
| b2 | 3.0 | | 3.40 |
| c | 0.40 | | 0.80 |
| D | 19.85 | | 20.15 |
| E | 15.45 | | 15.75 |
| e | 5.30 | 5.45 | 5.60 |
| L | 14.20 | | 14.80 |
| L1 | 3.70 | | 4.30 |
| L2 | | 18.50 | |
| ØP | 3.55 | | 3.65 |
| ØR | 4.50 | | 5.50 |
| S | 5.30 | 5.50 | 5.70 |

4.3 TO-247 long leads, STWA45N65M5

Figure 25. TO-247 long leads drawing



7395426_G

Table 11. TO-247 long leads mechanical data

| Dim. | mm | | |
|------|-----------|------|-------|
| | Min. | Typ. | Max. |
| A | 4.90 | | 5.15 |
| D | 1.85 | | 2.10 |
| E | 0.55 | | 0.67 |
| F | 1.07 | | 1.32 |
| F1 | 1.90 | | 2.38 |
| F2 | 2.87 | | 3.38 |
| G | 10.90 BSC | | |
| H | 15.77 | | 16.02 |
| L | 20.82 | | 21.07 |
| L1 | 4.16 | | 4.47 |
| L2 | 5.49 | | 5.74 |
| L3 | 20.05 | | 20.30 |
| L4 | 3.68 | | 3.93 |
| L5 | 6.04 | | 6.29 |
| M | 2.25 | | 2.55 |
| V | | 10° | |
| V1 | | 3° | |
| V3 | | 20° | |
| Dia. | 3.55 | | 3.66 |

5 Revision history

Table 12. Document revision history

| Date | Revision | Changes |
|-------------|----------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 11-Dec-2012 | 1 | First release. |
| 09-May-2014 | 2 | <ul style="list-style-type: none">– Added: TO-3PF package– Added: dv/dt (MOSFET dv/dt ruggedness) parameter and V_{ISO}– Modified: Figure 6 and 7– Minor text changes |

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